

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/626,762	WALKER ET AL.	
	Examiner	Art Unit	Page 1 of 2
Leigh Marie Garbowski	2825		

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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